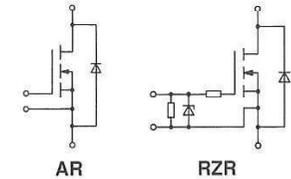
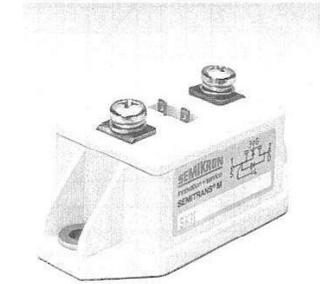


## SEMITRANS® M Power MOSFET Modules

SKM 111 AR  
SKM 111 RZR



### Features

- N Channel, enhancement mode
- Avalanche characteristic
- Short connections and built-in gate resistors to suppress internal oscillations even in critical applications
- Switching kW's in less than 1 μs
- Isolated copper baseplate
- All electrical connections on top for easy busbaring
- Large clearances and creepage distances
- UL recognized, file no. E 63 532

### Typical Applications

- Switched mode power supplies
- DC servo and robot drives
- DC choppers
- UPS equipment
- Not suitable for linear amplification

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Absolute Maximum Ratings			
Symbol	Conditions <sup>1)</sup>	Values	Units
V <sub>DS</sub>		100	V
V <sub>DGR</sub>	R <sub>GS</sub> = 20 kΩ	100	V
I <sub>D</sub>		200	A
I <sub>DM</sub>		600	A
V <sub>GS</sub>		AR: ± 20; RZR: <sup>+15</sup> <sub>-0.3</sub>	V
P <sub>D</sub>		700	W
T <sub>j</sub> , T <sub>stg</sub>		-55 ... +150	°C
V <sub>isol</sub>	AC, 1 min, 200 μA	2 500	V
humidity	DIN 40 040	Class F	
climate	DIN IEC 68 T.1	55/150/56	
Inverse Diode			
I <sub>F</sub> = -I <sub>D</sub>		200	A
I <sub>FM</sub> = -I <sub>DM</sub>		600	A

Characteristics					
Symbol	Conditions <sup>1)</sup>	min.	typ.	max.	Units
V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 0,25 mA	100	-	-	V
V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 1 mA	2,1	3,0	4,0	V
I <sub>DSS</sub>	V <sub>GS</sub> = 0, } T <sub>j</sub> = 25 °C	-	50	250	μA
	V <sub>DS</sub> = 100 V, } T <sub>j</sub> = 125 °C	-	300	1000	μA
I <sub>GSS</sub> <sup>3)</sup>	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0	-	10	100	nA
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 130 A	-	7	8,5	mΩ
g <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 130 A	60	75	-	S
C <sub>CHC</sub>		-	-	160	pF
C <sub>iss</sub>	} V <sub>GS</sub> = 0 V <sub>DS</sub> = 25 V f = 1 MHz	-	10	13	nF
C <sub>oss</sub>		-	5	7,5	nF
C <sub>rss</sub>		-	1,8	2,7	nF
L <sub>DS</sub>		-	-	20	nH
t <sub>d(on)</sub>	} V <sub>DD</sub> = 50 V I <sub>D</sub> = 130 A V <sub>GS</sub> = 10 V R <sub>GS</sub> = 3,3 Ω	-	60	-	ns
t <sub>r</sub>		-	220	-	ns
t <sub>d(off)</sub>		-	270	-	ns
t <sub>f</sub>		-	200	-	ns

Inverse Diode					
V <sub>SD</sub>	I <sub>F</sub> = 400 A, V <sub>GS</sub> = 0	-	1,25	1,6	V
t <sub>rr</sub>	T <sub>j</sub> = 25 °C <sup>2)</sup>	-	400	-	ns
	T <sub>j</sub> = 150 °C <sup>2)</sup>	-	-	-	ns
Q <sub>rr</sub>	T <sub>j</sub> = 25 °C <sup>2)</sup>	-	3,5	-	μC
	T <sub>j</sub> = 150 °C <sup>2)</sup>	-	-	-	μC

Thermal Characteristics					
R <sub>thjc</sub>		-	-	0,18	°C/W
R <sub>thch</sub>	M1, surface 10 μm	-	-	0,05	°C/W

Mechanical Data					
M1	to heatsink, SI Units	4	-	6	Nm
	to heatsink, US Units	35	-	53	lb.in.
M2	for terminals, SI Units	2,5	-	3,5	Nm
	for terminals, US Units	22	-	24	lb.in.
a		-	-	5x9,81	m/s <sup>2</sup>
w		-	-	150	g
Case	→ page B 6 - 69	AR: D 15; RZR: D 45			

1) T<sub>case</sub> = 25 °C, unless otherwise specified.  
2) I<sub>F</sub> = -I<sub>D</sub>, V<sub>R</sub> = 100 V, -di<sub>F</sub>/dt = 100 A/μs  
3) RZR: V<sub>GS</sub> = 12 V; V<sub>DS</sub> = 0; I<sub>GSS</sub> = typ. 120 μA

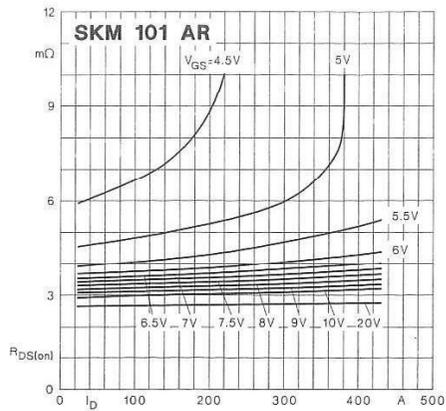


Fig. 13 On-resistance vs. drain current

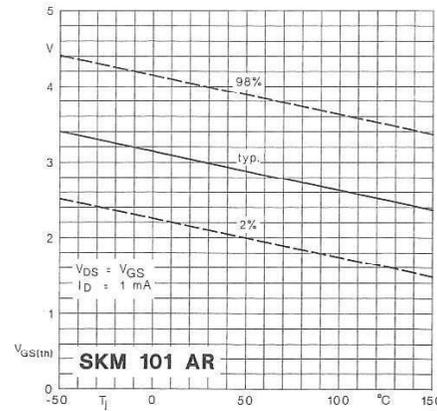


Fig. 14 Gate-source threshold voltage

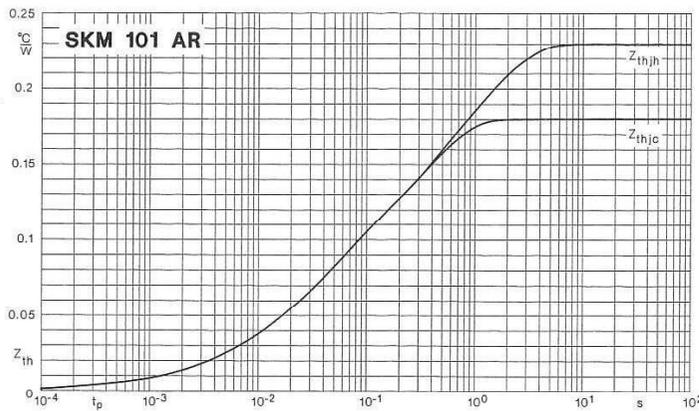


Fig. 51 Transient thermal impedance

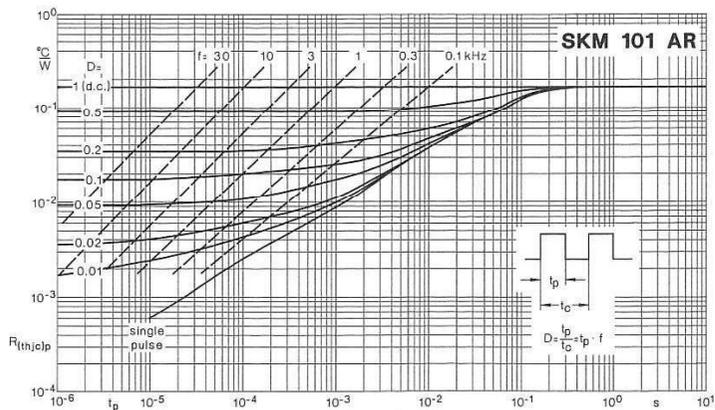


Fig. 52 Thermal impedance under pulse conditions

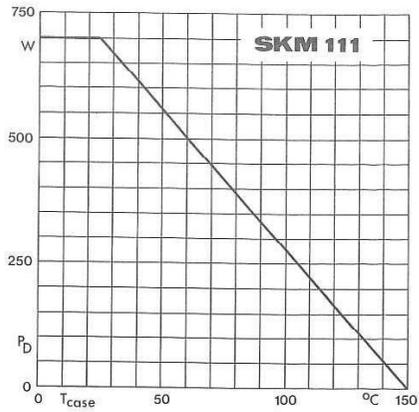


Fig. 1 Rated power dissipation vs. temperature

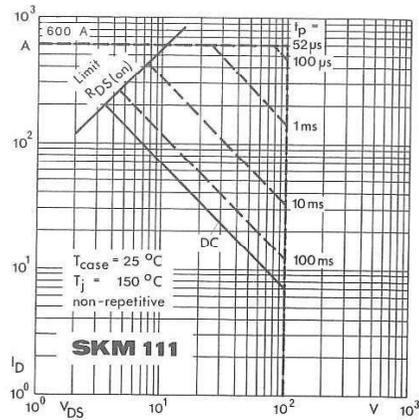


Fig. 2 Maximum safe operating area

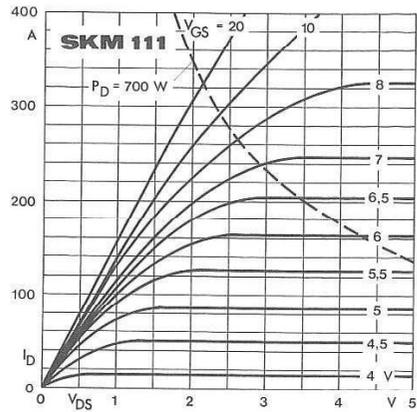


Fig. 3 Output characteristic

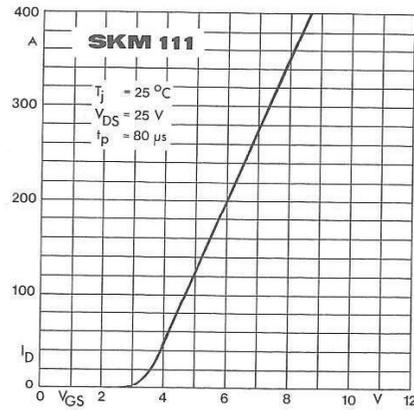


Fig. 4 Transfer characteristic

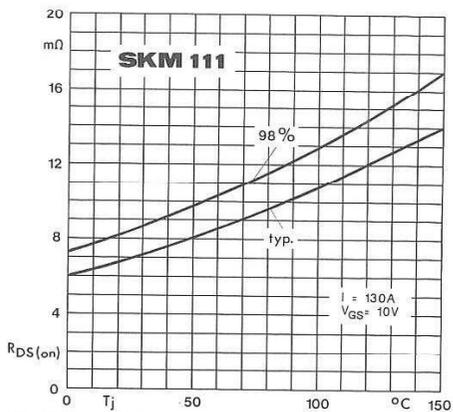


Fig. 5 On-resistance vs. temperature

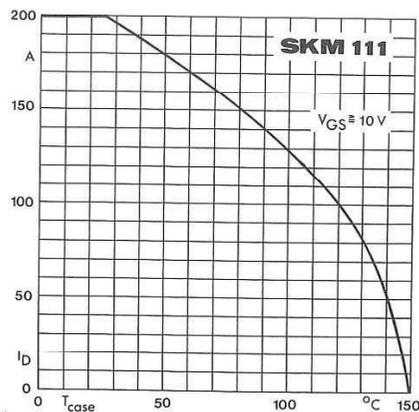


Fig. 6 Rated current vs. temperature

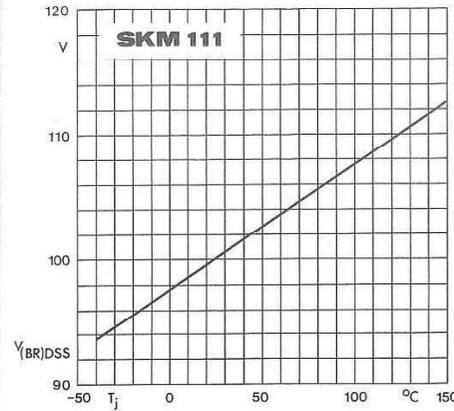


Fig. 7 Breakdown voltage vs. temperature

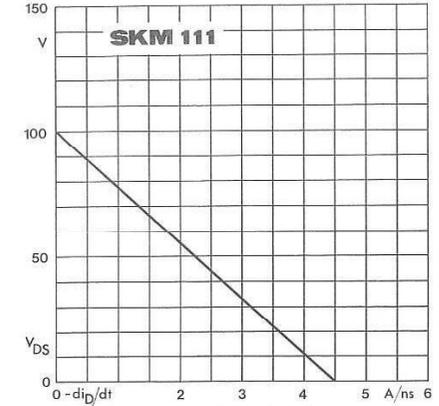


Fig. 8 Drain-source voltage derating

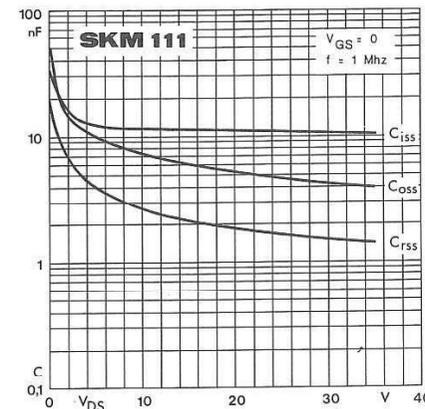


Fig. 9 Capacitances vs. drain-source voltage

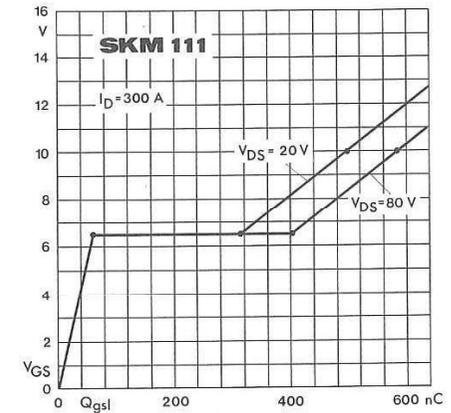


Fig. 10 Gate charge characteristic

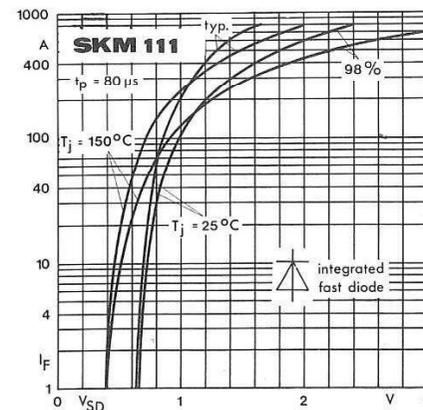
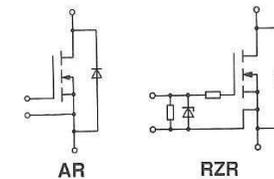
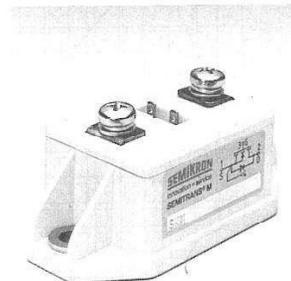


Fig. 11 Diode forward characteristic

## SEMITRANS® M Power MOSFET Modules

SKM 121 AR  
SKM 121 RZR



### Features

- N Channel, enhancement mode
- Avalanche characteristic
- Short internal connections avoid oscillations
- Switching kW's in less than 1 μs
- Isolated copper baseplate
- All electrical connections on top for easy busbaring
- Large clearances and creepage distances
- UL recognized, file no. E 63 532

### Typical Applications

- Switched mode power supplies
- DC servo and robot drives
- DC choppers
- UPS equipment
- Plasma cutting
- Not suitable for linear amplification

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Absolute Maximum Ratings		Values	Units
Symbol	Conditions <sup>1)</sup>		
V <sub>DS</sub>		200	V
V <sub>DGR</sub>	R <sub>GS</sub> = 20 kΩ	200	V
I <sub>D</sub>		130	A
I <sub>DM</sub>		390	A
V <sub>GS</sub>		AR: ± 20; RZR: +15, -0,3	V
P <sub>D</sub>		700	W
T <sub>J</sub> , T <sub>stg</sub>		-55...+150	°C
V <sub>isol</sub>	AC, 1 min, 200 μA	2 500	V
humidity	DIN 40 040	Class F	
climate	DIN IEC 68 T.1	55/150/56	
Inverse Diode			
I <sub>F</sub> = -I <sub>D</sub>		130	A
I <sub>FM</sub> = -I <sub>DM</sub>		390	A

Characteristics		min.	typ.	max.	Units
Symbol	Conditions <sup>1)</sup>				
V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 0,25 mA	200	-	-	V
V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 1 mA	2,1	3,0	4,0	V
I <sub>DSS</sub>	V <sub>GS</sub> = 0, } T <sub>J</sub> = 25 °C V <sub>DS</sub> = 200 V } T <sub>J</sub> = 125 °C	-	50	250	μA
I <sub>GSS</sub> <sup>3)</sup>	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0	-	300	1000	μA
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A	-	18	20	mΩ
g <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 80 A	60	75	-	S

C <sub>CHC</sub>	} V <sub>GS</sub> = 0 V <sub>DS</sub> = 25 V f = 1 MHz	-	-	160	pF
C <sub>iss</sub>		-	10	13	nF
C <sub>oss</sub>		-	3	4,5	nF
C <sub>rss</sub>		-	0,7	1	nF
L <sub>DS</sub>		-	-	20	nH
t <sub>d(on)</sub>	} V <sub>DD</sub> = 100 V I <sub>D</sub> = 80 A	-	60	-	ns
t <sub>r</sub>		-	60	-	ns
t <sub>d(off)</sub>	} V <sub>GS</sub> = 10 V R <sub>GS</sub> = 3,3 Ω	-	240	-	ns
t <sub>f</sub>		-	70	-	ns

Inverse Diode					Units
V <sub>SD</sub>	I <sub>F</sub> = 260 A, V <sub>GS</sub> = 0	-	1,05	1,4	V
t <sub>rr</sub>	T <sub>J</sub> = 25 °C <sup>2)</sup>	-	400	-	ns
	T <sub>J</sub> = 150 °C <sup>2)</sup>	-	-	-	ns
Q <sub>rr</sub>	T <sub>J</sub> = 25 °C <sup>2)</sup>	-	4,3	-	μC
	T <sub>J</sub> = 150 °C <sup>2)</sup>	-	-	-	

Thermal Characteristics					Units
R <sub>thjc</sub>		-	-	0,18	°C/W
R <sub>thch</sub>	M1, surface 10 μm	-	-	0,05	°C/W

Mechanical Data					Units
M1	to heatsink, SI Units	4	-	6	Nm
	to heatsink, US Units	35	-	53	lb.in.
M2	for terminals, SI Units	2,5	-	3,5	Nm
	for terminals, US Units	22	-	24	lb.in.
a		-	-	5x9,81	m/s <sup>2</sup>
w		-	-	150	g
Case	→ page B 6 - 69	AR: D 15; RZR: D 45			

<sup>1)</sup> T<sub>case</sub> = 25 °C, unless otherwise specified.

<sup>2)</sup> I<sub>F</sub> = -I<sub>D</sub>, V<sub>R</sub> = 100 V, -di<sub>F</sub>/dt = 100 A/μs

<sup>3)</sup> RZR: V<sub>GS</sub> = 12 V; V<sub>DS</sub> = 0; I<sub>GSS</sub> = typ. 120 μA

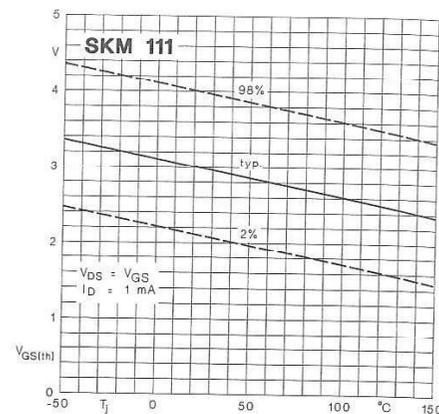


Fig. 14 Gate-source threshold voltage

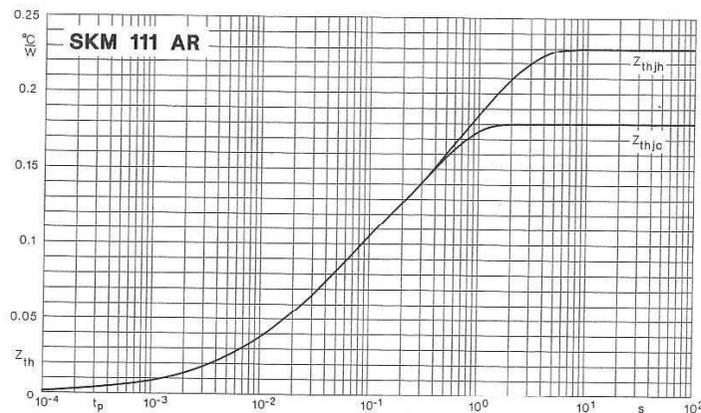


Fig. 51 Transient thermal impedance

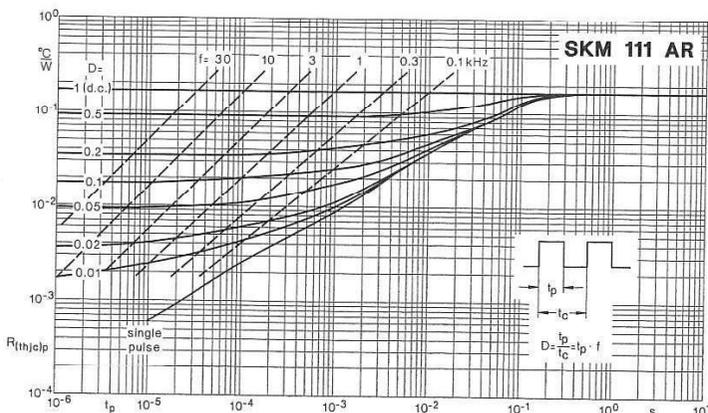


Fig. 52 Thermal impedance under pulse conditions

UL recognized, file no. E 63 532

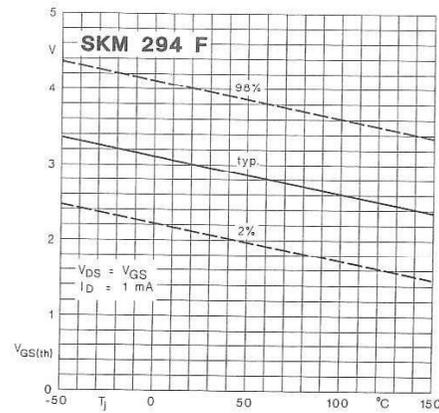


Fig. 14 Gate-source threshold voltage

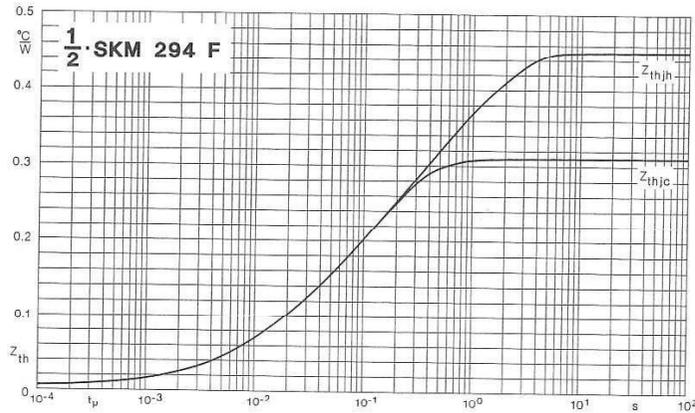


Fig. 51 Transient thermal impedance

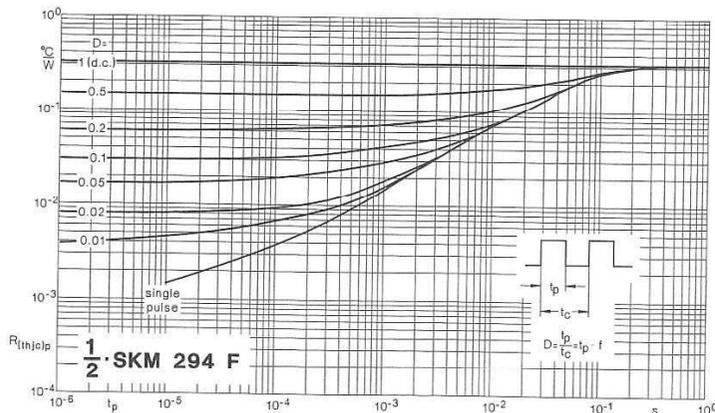
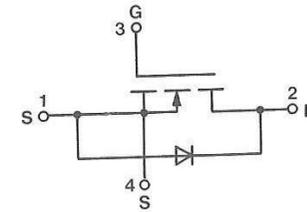
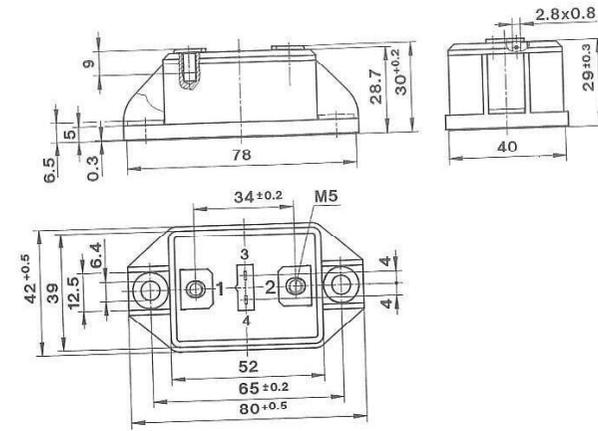


Fig. 52 Thermal impedance under pulse conditions

- SKM 101 AR
- SKM 111 AR
- SKM 121 AR
- SKM 141
- SKM 151
- SKM 151 F
- SKM 181
- SKM 181 F
- SKM 191
- SKM 191 F

Case D 15



Dimensions in mm

- SKM 101 RZR
- SKM 111 RZR
- SKM 121 RZR

Case D 45 (→ D 15)

